

**HEXFET® POWER MOSFET
SURFACE MOUNT (SMD-0.5)**

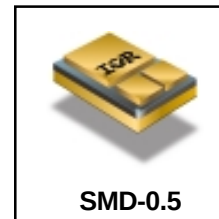
**IRL5NJ7413
30V, N-CHANNEL**

Product Summary

Part Number	BVDSS	RDS(on)	ID
IRL5NJ7413	30V	0.014Ω	22A*

Fifth Generation HEXFET® power MOSFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon unit area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

These devices are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers and high-energy pulse circuits.



Features:

- Low RDS(on)
- Avalanche Energy Ratings
- Dynamic dv/dt Rating
- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Surface Mount
- Light Weight

Absolute Maximum Ratings

	Parameter		Units
ID @ VGS = 10V, TC = 25°C	Continuous Drain Current	22*	A
ID @ VGS = 10V, TC = 100°C	Continuous Drain Current	22*	
IDM	Pulsed Drain Current ①	88	
PD @ TC = 25°C	Max. Power Dissipation	75	W
	Linear Derating Factor	0.60	W/°C
VGS	Gate-to-Source Voltage	±16	V
EAS	Single Pulse Avalanche Energy ②	190	mJ
IAR	Avalanche Current ①	22	A
EAR	Repetitive Avalanche Energy ①	7.5	mJ
dv/dt	Peak Diode Recovery dv/dt ③	1.0	V/ns
TJ	Operating Junction	-55 to 150	°C
TSTG	Storage Temperature Range		
	Package Mounting Surface Temperature	300 (for 5 s)	
	Weight	1.0	g

* Current is limited by package

For footnotes refer to the last page

Electrical Characteristics @ T_j = 25°C (Unless Otherwise Specified)

	Parameter	Min	Typ	Max	Units	Test Conditions
B _{VDSS}	Drain-to-Source Breakdown Voltage	30	—	—	V	V _{GS} = 0V, I _D = 250μA
ΔB _{VDSS} /ΔT _j	Temperature Coefficient of Breakdown Voltage	—	0.027	—	V/°C	Reference to 25°C, I _D = 1.0mA
R _{DS(on)}	Static Drain-to-Source On-State Resistance	—	—	0.014 — 0.020	Ω	V _{GS} = 10V, I _D = 22A ④ V _{GS} = 4.5V, I _D = 22A
V _{GS(th)}	Gate Threshold Voltage	1.0	—	—	V	V _{DS} = V _{GS} , I _D = 250μA
g _{fs}	Forward Transconductance	30	—	—	S (r)	V _{DS} = 10V, I _{DS} = 22A ④
I _{DSS}	Zero Gate Voltage Drain Current	—	—	25 — 250	μA	V _{DS} = 30V, V _{GS} = 0V V _{DS} = 24V, V _{GS} = 0V, T _j = 125°C
I _{GSS}	Gate-to-Source Leakage Forward	—	—	100	nA	V _{GS} = 16V
I _{GSS}	Gate-to-Source Leakage Reverse	—	—	-100	nA	V _{GS} = -16V
Q _g	Total Gate Charge	—	—	70	nC	V _{GS} = 10V, I _D = 22A
Q _{gs}	Gate-to-Source Charge	—	—	20	nC	V _{DS} = 24V
Q _{gd}	Gate-to-Drain ('Miller') Charge	—	—	23	nC	
t _{d(on)}	Turn-On Delay Time	—	—	20	ns	V _{DD} = 15V, I _D = 22A, V _{GS} = 10V, R _G = 6.2Ω
t _r	Rise Time	—	—	80	ns	
t _{d(off)}	Turn-Off Delay Time	—	—	80	ns	
t _f	Fall Time	—	—	80	ns	
L _S + L _D	Total Inductance	—	4.0	—	nH	Measured from the center of drain pad to center of source pad
C _{iss}	Input Capacitance	—	1640	—	pF	V _{GS} = 0V, V _{DS} = 25V f = 1.0MHz
C _{oss}	Output Capacitance	—	660	—	pF	
C _{rss}	Reverse Transfer Capacitance	—	80	—	pF	

Source-Drain Diode Ratings and Characteristics

	Parameter	Min	Typ	Max	Units	Test Conditions
I _S	Continuous Source Current (Body Diode)	—	—	22*	A	
I _{SM}	Pulse Source Current (Body Diode) ①	—	—	88		
V _{SD}	Diode Forward Voltage	—	—	1.0	V	T _J = 25°C, I _S = 22A, V _{GS} = 0V ④
t _{rr}	Reverse Recovery Time	—	—	120	nS	T _J = 25°C, I _F = 22A, di/dt ≤ 100A/μs V _{DD} ≤ 25V ④
Q _{RR}	Reverse Recovery Charge	—	—	300	nC	
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by L _S + L _D .				

* Current is limited by package

Thermal Resistance

	Parameter	Min	Typ	Max	Units	Test Conditions
R _{thJC}	Junction-to-Case	—	—	1.67	°C/W	

Note: Corresponding Spice and Saber models are available on the G&S Website.

For footnotes refer to the last page

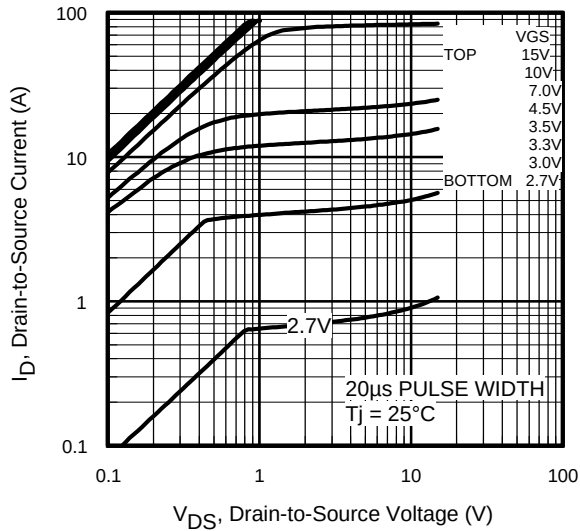


Fig 1. Typical Output Characteristics

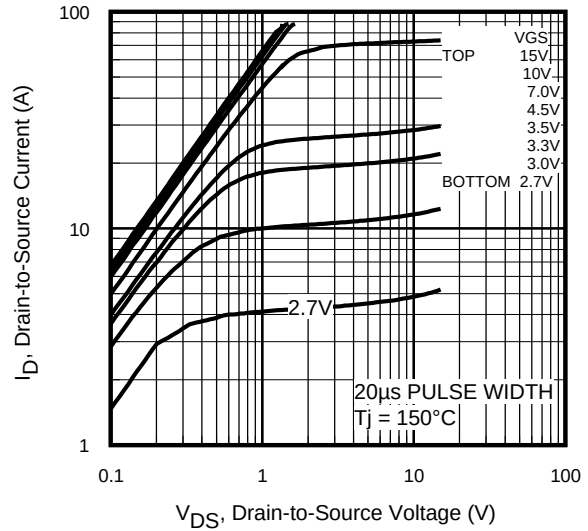


Fig 2. Typical Output Characteristics

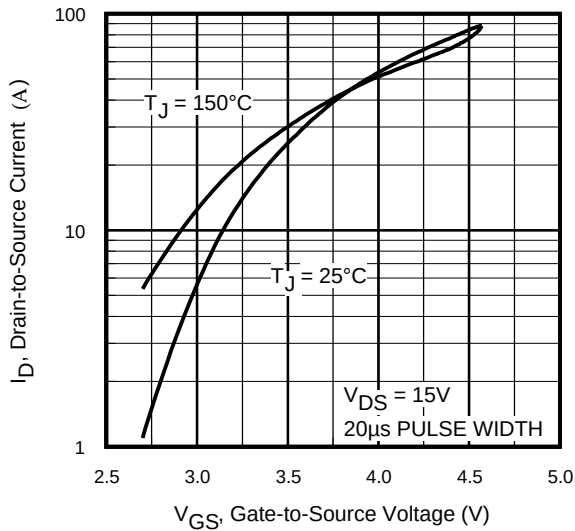


Fig 3. Typical Transfer Characteristics

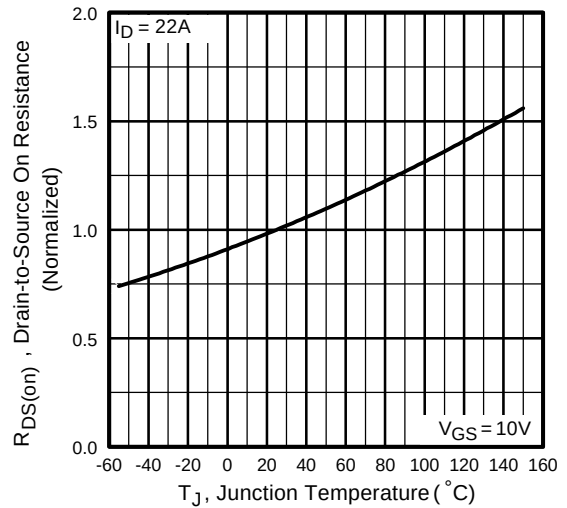
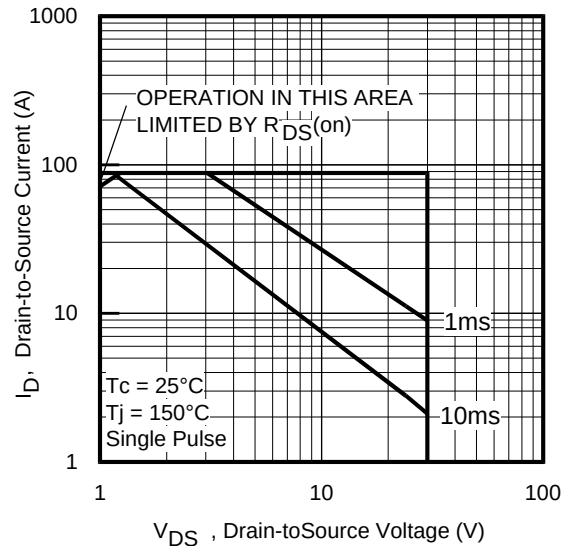
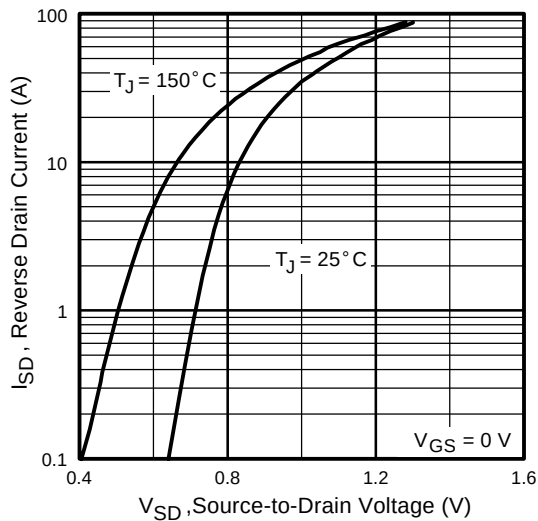
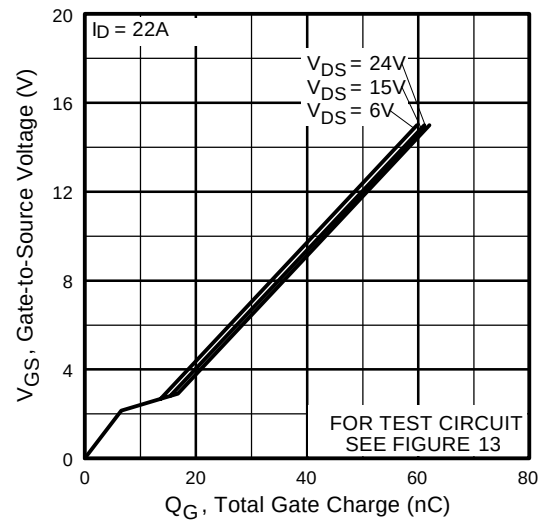
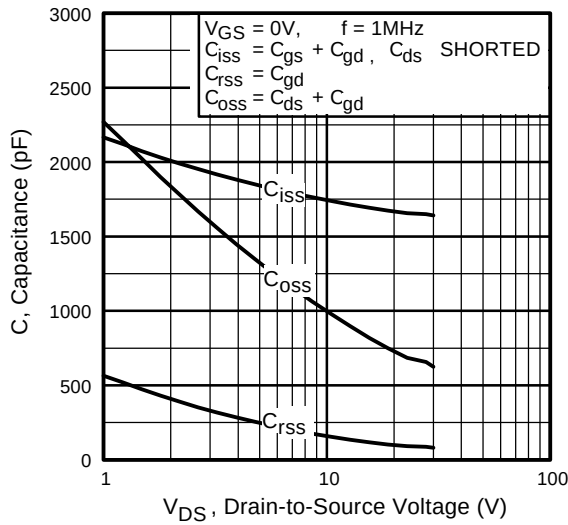


Fig 4. Normalized On-Resistance Vs. Temperature



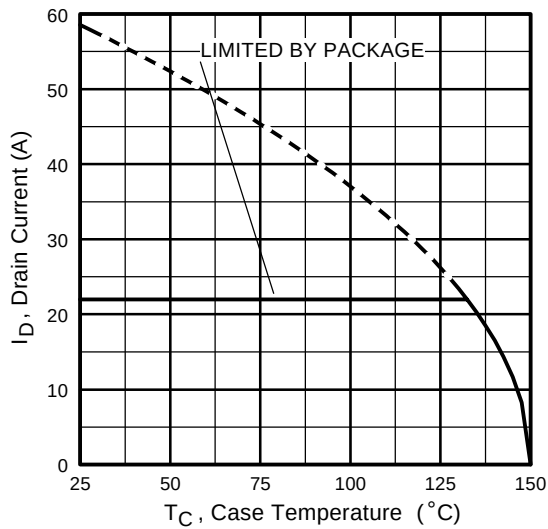


Fig 9. Maximum Drain Current Vs. Case Temperature

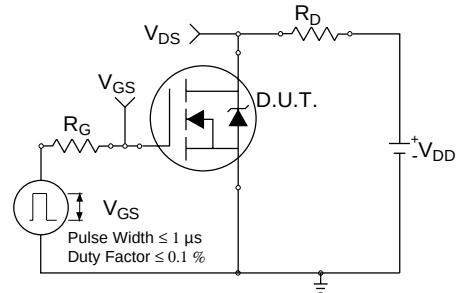


Fig 10a. Switching Time Test Circuit

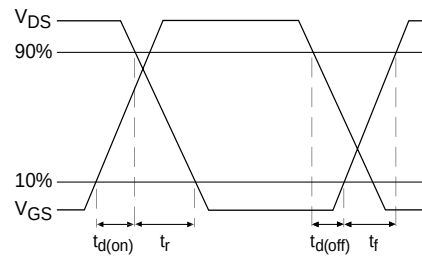


Fig 10b. Switching Time Waveforms

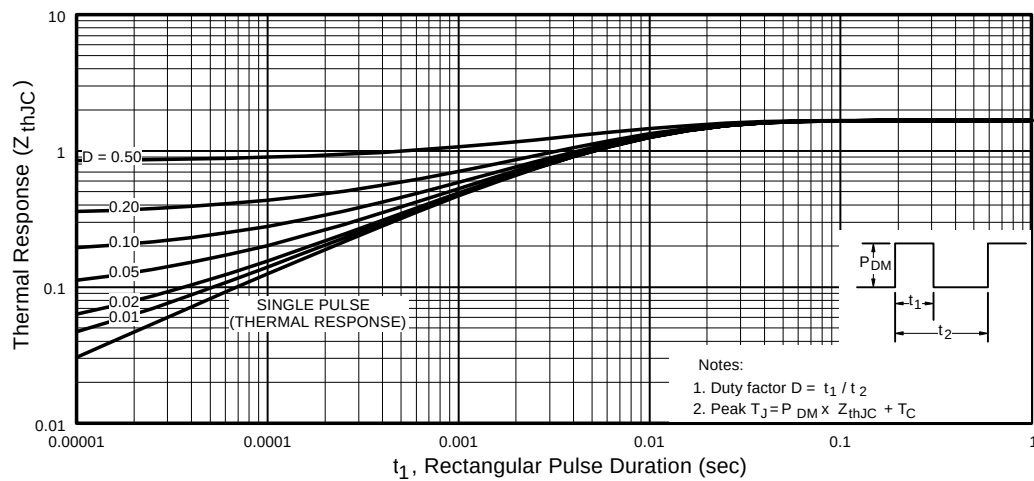
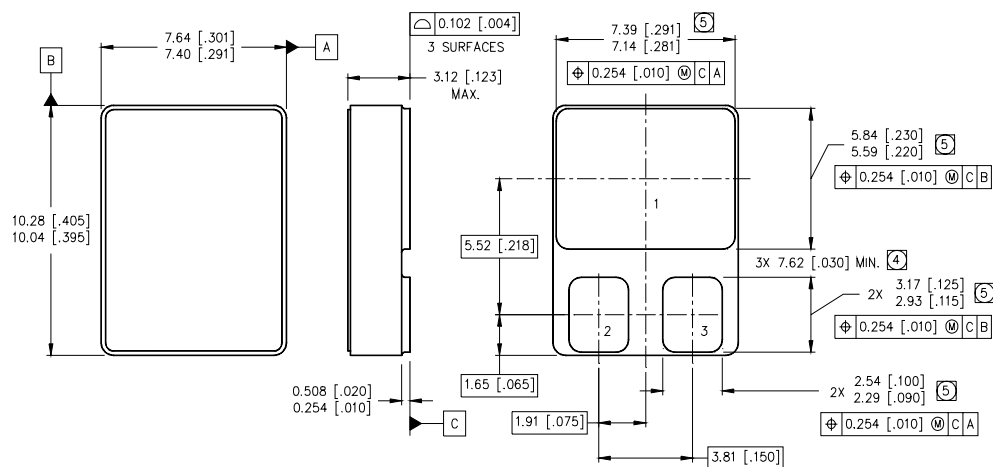


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
 - ② $V_{DD} = 25\text{ V}$, Starting $T_J = 25^\circ\text{C}$, $L = 0.8\text{ mH}$
Peak $I_{AS} = 22\text{ A}$, $V_{GS} = 10\text{ V}$, $R_G = 25\Omega$
 - ③ $I_{SD} \leq 22\text{ A}$, $di/dt \leq 140\text{ A}/\mu\text{s}$,
 $V_{DD} \leq 30\text{ V}$, $T_J \leq 150^\circ\text{C}$
 - ④ Pulse width $\leq 300\text{ }\mu\text{s}$; Duty Cycle $\leq 2\%$

Case Outline and Dimensions — SMD-0.5



NOTES:

1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
4. DIMENSION INCLUDES METALLIZATION FLASH.
5. DIMENSION DOES NOT INCLUDE METALLIZATION FLASH.

PAD ASSIGNMENTS

- 1 = DRAIN
2 = GATE
3 = SOURCE

International
IOR Rectifier

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105
TAC Fax: (310) 252-7903

Visit us at www.irf.com for sales contact information.

Data and specifications subject to change without notice. 07/01